Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/670,062	BUCHERT ET AL.	
Examiner	Art Unit	
Tan V Mai	2193	

	SEARCHED			
Class	Subclass	Date	Examiner	
708	490, 524	4/20/2007	MAI	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	4/20/2007	MAI		
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